

**Notice of References Cited**Application/Control No.  
10/012,215Applicant(s)/Patent Under  
Reexamination  
ITO ET AL.Examiner  
Christopher R. MageeArt Unit  
2653

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,703,470	10-1987	Castagna et al.	369/215
*	B	US-5,608,705 A	03-1997	Tanaka, Akira	369/77.1
*	C	US-6,002,658 A	12-1999	Aso et al.	369/75.1
*	D	US-6,456,580 B2	09-2002	Lee, Wei-Pang	369/75.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 58035701 A	03-1983	Japan	NAKAHIRA, SHUTARO	G11B 01/00
*	O	JP 02098863 A	04-1990	Japan	KOIZUMI, SATORU	G11B 17/04
*	P	JP 05054621 A	03-1993	Japan	MASUDA et al.	G11B 33/08
*	Q	JP 08021486 A	01-1996	Japan	HAYASHI, KENJI	F16F 15/08
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Translation of Kiyoshi et al. JP 10-208357, 08-07-1998.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.